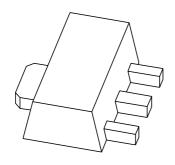
### **DISCRETE SEMICONDUCTORS**

## DATA SHEET



PBSS5480X 80 V, 4 A PNP low V<sub>CEsat</sub> (BISS) transistor

Product specification Supersedes data of 2004 Jun 8 2004 Nov 08





### 80 V, 4 A PNP low V<sub>CEsat</sub> (BISS) transistor

### **PBSS5480X**

### **FEATURES**

- High hFE and low VCEsat at high current operation
- High collector current I<sub>C</sub>: 4 A
- High efficiency leading to less heat generation.

### **APPLICATIONS**

- Medium power peripheral drivers (e.g. fans and motors)
- Strobe flash units for digital still cameras and mobile phones
- Inverter applications (e.g. TFT displays)
- · Power switch for LAN and ADSL systems
- Medium power DC-to-DC conversion
- · Battery chargers.

### **DESCRIPTION**

PNP low V<sub>CEsat</sub> (BISS) transistor in a SOT89 (SC-62) plastic package.

NPN complement: PBSS4480X.

### **MARKING**

TYPE NUMBER	MARKING CODE <sup>(1)</sup>
PBSS5480X	*1Z

### Note

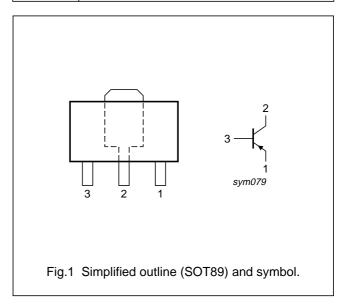
- 1. \* = p: made in Hong Kong.
  - \* = t: made in Malaysia.
  - \* = W: made in China.

### **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	MAX.	UNIT
V <sub>CEO</sub>	collector-emitter voltage	-80	V
I <sub>C</sub>	collector current (DC)	-4	Α
I <sub>CM</sub>	peak collector current	-10	Α
R <sub>CEsat</sub>	equivalent on-resistance	75	mΩ

### **PINNING**

PIN	DESCRIPTION
1	emitter
2	collector
3	base



### **ORDERING INFORMATION**

TYPE NUMBER	PACKAGE				
I I FE NOWBER	NAME	DESCRIPTION	VERSION		
PBSS5480X	SC-62	plastic surface mounted package; collector pad for good heat transfer; 3 leads	SOT89		

## 80 V, 4 A PNP low $V_{CEsat}$ (BISS) transistor

PBSS5480X

### **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 60134).

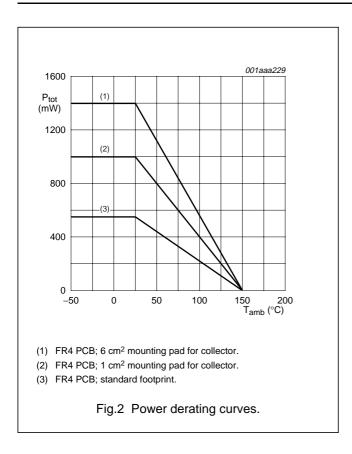
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CBO</sub>	collector-base voltage	open emitter	_	-80	V
V <sub>CEO</sub>	collector-emitter voltage	open base	_	-80	V
V <sub>EBO</sub>	emitter-base voltage	open collector	_	-5	V
I <sub>C</sub>	collector current (DC)	note 1	_	-4	А
I <sub>CM</sub>	peak collector current	$t_p \le 1$ ms or limited by $T_{j(max)}$	_	-10	А
I <sub>CRP</sub>	repetitive peak collector current	$t_p \le 10 \text{ ms}; \ \delta \le 0.1$	_	-6	А
I <sub>B</sub>	base current (DC)		_	-1	А
I <sub>BM</sub>	peak base current	$t_p \le 1 \text{ ms}$	_	-2	А
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C			
		notes 2 and 3	_	2.5	W
		note 3	_	0.55	W
		note 4	_	1	W
		note 1	_	1.4	W
		note 5	_	1.6	W
T <sub>stg</sub>	storage temperature		-65	+150	°C
T <sub>j</sub>	junction temperature		_	150	°C
T <sub>amb</sub>	ambient temperature		-65	+150	°C

### **Notes**

- Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.
- 2. Operated under pulsed conditions; pulse width  $t_p \le 10$  ms; duty cycle  $\delta \le 0.1$ .
- 3. Device mounted on a printed-circuit board, single-sided copper, tin-plated, standard footprint.
- 4. Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- 5. Device mounted on a 7 cm² ceramic printed-circuit board, 1 cm² single-sided copper, tin-plated.

## 80 V, 4 A PNP low $V_{CEsat}$ (BISS) transistor

PBSS5480X



### 80 V, 4 A PNP low V<sub>CEsat</sub> (BISS) transistor

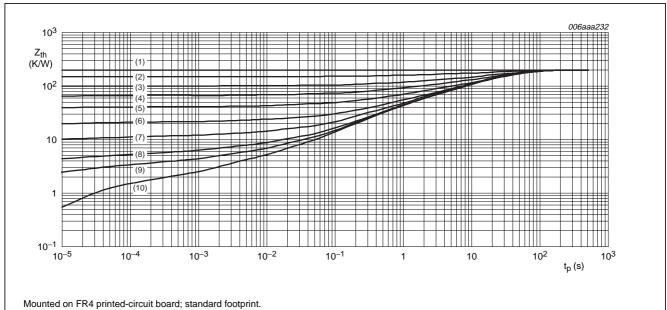
PBSS5480X

### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	in free air		
		notes 1 and 2	50	K/W
		note 2	225	K/W
		note 3	125	K/W
		note 4	90	K/W
		note 5	80	K/W
R <sub>th(j-s)</sub>	thermal resistance from junction to soldering point		16	K/W

### **Notes**

- Operated under pulsed conditions; pulse width  $t_p \leq 10$  ms; duty cycle  $\delta \leq 0.2.$
- 2. Device mounted on a printed-circuit board, single-sided copper, tin-plated, standard footprint.
- Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>. 3.
- Device mounted on a printed-circuit board, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.
- Device mounted on a 7 cm<sup>2</sup> ceramic printed-circuit board, 1 cm<sup>2</sup> single-sided copper, tin-plated.



Mounted on FR4 printed-circuit board; standard footprint.

- (1)  $\delta = 1$ .
- (3)  $\delta = 0.5$ .
- (5)  $\delta = 0.2$ .
- (7)  $\delta = 0.05$ .
- (9)  $\delta = 0.01$ .

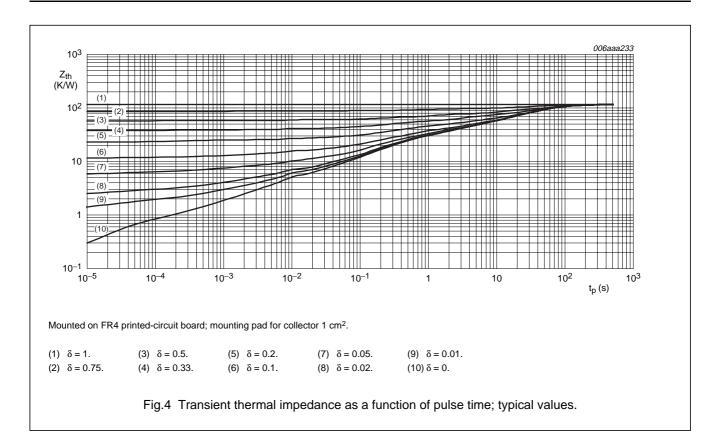
- (2)  $\delta = 0.75$ .
- (4)  $\delta = 0.33$ .
- (6)  $\delta = 0.1$ .
- (8)  $\delta = 0.02$ .
- (10)  $\delta = 0$ .

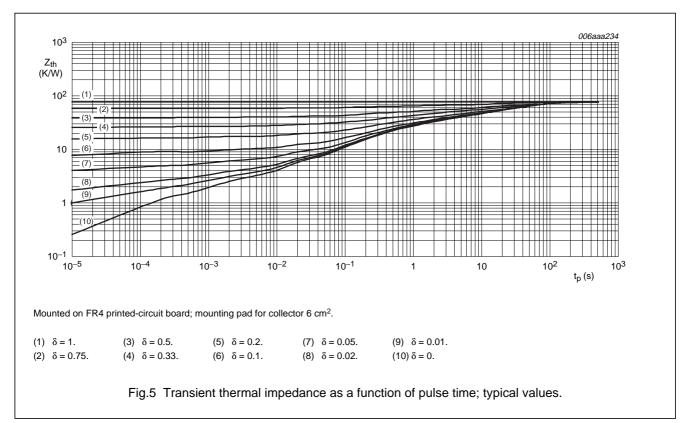
Fig.3 Transient thermal impedance as a function of pulse time; typical values.

2004 Nov 08 5

## 80 V, 4 A PNP low $V_{CEsat}$ (BISS) transistor

PBSS5480X





# 80 V, 4 A PNP low $V_{\text{CEsat}}$ (BISS) transistor

PBSS5480X

### **CHARACTERISTICS**

 $T_{amb}$  = 25 °C unless otherwise specified.

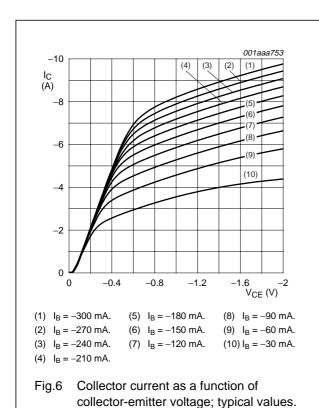
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I <sub>CBO</sub>	collector-base cut-off current $V_{CB} = -80 \text{ V}; I_E = 0 \text{ A}$		_	_	-100	nA
		$V_{CB} = -80 \text{ V}; I_E = 0 \text{ A}; T_j = 150 ^{\circ}\text{C}$	_	_	-50	μΑ
I <sub>CES</sub>	collector-emitter cut-off current	$V_{CE} = -60 \text{ V}; V_{BE} = 0 \text{ V}$	_	_	-100	nA
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_C = 0 \text{ A}$	_	_	-100	nA
h <sub>FE</sub>	DC current gain	$V_{CE} = -2 \text{ V}; I_{C} = -0.5 \text{ A}$	200	300	_	
		$V_{CE} = -2 \text{ V}; I_{C} = -1 \text{ A}; \text{ note 1}$	180	280	_	
		$V_{CE} = -2 \text{ V}; I_{C} = -2 \text{ A}; \text{ note 1}$	150	240	_	
		$V_{CE} = -2 \text{ V}; I_{C} = -4 \text{ A}; \text{ note 1}$	80	150	_	
V <sub>CEsat</sub>	collector-emitter saturation voltage	$I_C = -0.5 \text{ A}; I_B = -50 \text{ mA}$	_	-35	<b>-55</b>	mV
		$I_C = -1 \text{ A}; I_B = -50 \text{ mA}$	_	-70	-105	mV
		$I_C = -2 \text{ A}; I_B = -40 \text{ mA}$	_	-170	-250	mV
		$I_C = -4 \text{ A}$ ; $I_B = -200 \text{ mA}$ ; note 1	_	-220	-340	mV
		$I_C = -5 \text{ A}$ ; $I_B = -500 \text{ mA}$ ; note 1	_	-250	-380	mV
R <sub>CEsat</sub>	equivalent on-resistance	$I_C = -5 \text{ A}$ ; $I_B = -500 \text{ mA}$ ; note 1	_	50	75	mΩ
V <sub>BEsat</sub>	base-emitter saturation voltage	$I_C = -0.5 \text{ A}; I_B = -50 \text{ mA}$	_	-770	-850	mV
		$I_C = -1 \text{ A}; I_B = -50 \text{ mA}$	_	-810	-900	mV
		$I_C = -1 \text{ A}$ ; $I_B = -100 \text{ mA}$ ; note 1	_	-810	-900	mV
		$I_C = -4 \text{ A}$ ; $I_B = -400 \text{ mA}$ ; note 1	_	-930	-1000	mV
V <sub>BEon</sub>	base-emitter turn-on voltage	$V_{CE} = -2 \text{ V}; I_{C} = -2 \text{ A}$	_	-760	-850	mV
f <sub>T</sub>	transition frequency	$I_C = -0.1 \text{ A}; V_{CE} = -10 \text{ V};$ f = 100 MHz	100	125	_	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	_	60	90	pF

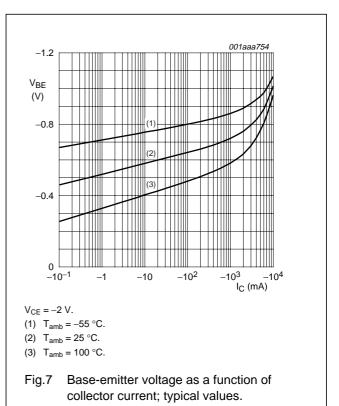
### Note

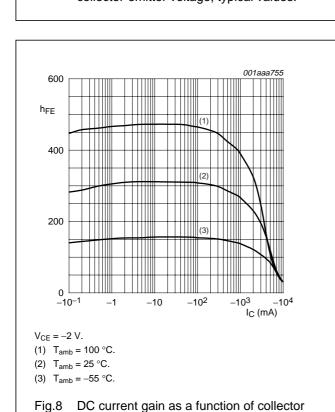
1. Pulse test:  $t_p \le 300 \ \mu s; \ \delta \le 0.02.$ 

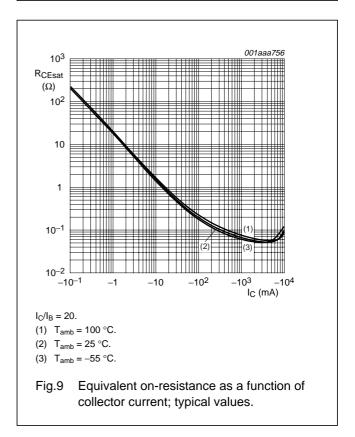
## 80 V, 4 A PNP low $V_{CEsat}$ (BISS) transistor

### PBSS5480X







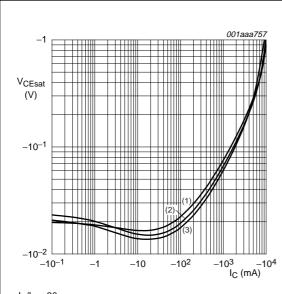


2004 Nov 08 8

current; typical values.

## 80 V, 4 A PNP low $V_{CEsat}$ (BISS) transistor

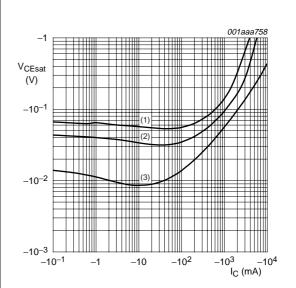
### PBSS5480X



 $I_{\rm C}/I_{\rm B} = 20.$ 

- (1)  $T_{amb} = 100 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = -55 \, ^{\circ}C$ .

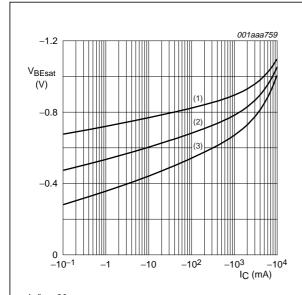
Fig.10 Collector-emitter saturation voltage as a function of collector current; typical values.



 $T_{amb} = 25 \, ^{\circ}C.$ 

- (1)  $I_C/I_B = 100$
- (2)  $I_C/I_B = 50$ .
- (3)  $I_C/I_B = 10$ .

Fig.11 Collector-emitter saturation voltage as a function of collector current; typical values.



 $I_{\rm C}/I_{\rm B}=20.$ 

- (1)  $T_{amb} = -55 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = 100 \, ^{\circ}C$ .

Fig.12 Base-emitter saturation voltage as a function of collector current; typical values.

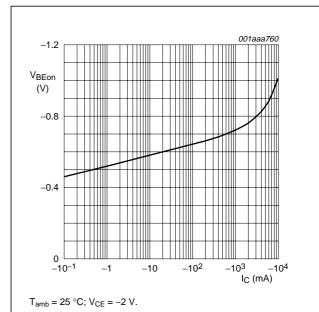
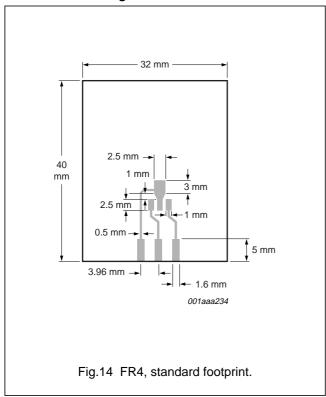


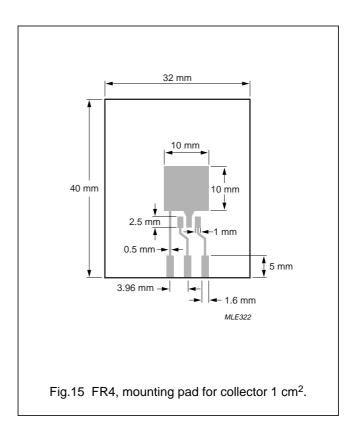
Fig.13 Base-emitter turn-on voltage as a function of collector current; typical values.

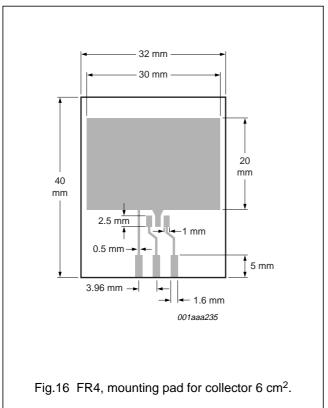
## 80 V, 4 A PNP low $V_{CEsat}$ (BISS) transistor

### PBSS5480X

### Reference mounting conditions







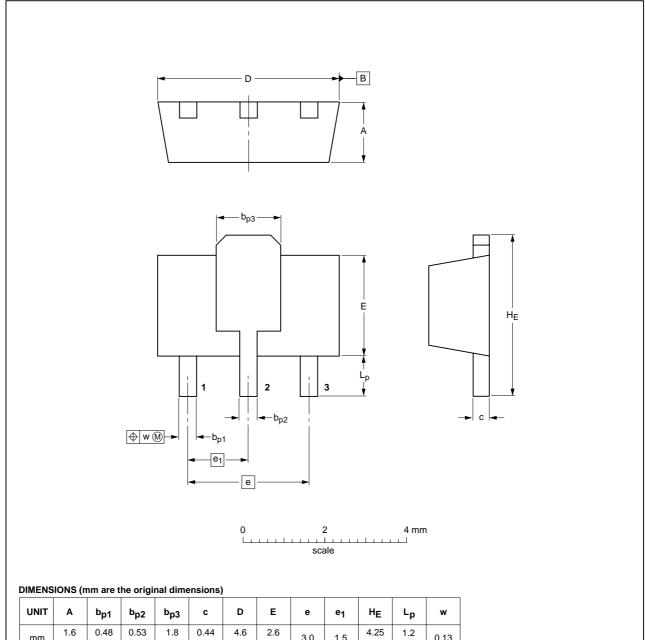
80 V, 4 A PNP low  $V_{CEsat}$  (BISS) transistor

PBSS5480X

### **PACKAGE OUTLINE**

### Plastic surface mounted package; collector pad for good heat transfer; 3 leads

**SOT89** 



UNIT	A	b <sub>p1</sub>	b <sub>p2</sub>	b <sub>p3</sub>	С	D	E	е	e <sub>1</sub>	HE	Lp	w
mm	1.6 1.4	0.48 0.35	0.53 0.40	1.8 1.4	0.44 0.23	4.6 4.4	2.6 2.4	3.0	1.5	4.25 3.75	1.2 0.8	0.13

OUTLINE		REFER	ENCES	EUROPEAN ISSUE DA		
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE	
SOT89		TO-243	SC-62		<del>99-09-13</del> 04-08-03	

2004 Nov 08 11

80 V, 4 A PNP low V<sub>CEsat</sub> (BISS) transistor

PBSS5480X

#### **DATA SHEET STATUS**

LEVEL	DATA SHEET STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)(3)</sup>	DEFINITION
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
III	Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN).

#### **Notes**

- 1. Please consult the most recently issued data sheet before initiating or completing a design.
- 2. The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.
- 3. For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

#### **DEFINITIONS**

**Short-form specification** — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information — Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors make no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

#### **DISCLAIMERS**

Life support applications — These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips Semiconductors customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips Semiconductors for any damages resulting from such application.

Right to make changes — Philips Semiconductors reserves the right to make changes in the products - including circuits, standard cells, and/or software - described or contained herein in order to improve design and/or performance. When the product is in full production (status 'Production'), relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN). Philips Semiconductors assumes no responsibility or liability for the use of any of these products, conveys no licence or title under any patent, copyright, or mask work right to these products, and makes no representations or warranties that these products are free from patent, copyright, or mask work right infringement, unless otherwise specified.

### Philips Semiconductors – a worldwide company

#### **Contact information**

For additional information please visit http://www.semiconductors.philips.com. Fax: +31 40 27 24825 For sales offices addresses send e-mail to: sales.addresses@www.semiconductors.philips.com.

© Koninklijke Philips Electronics N.V. 2004

SCA76

All rights are reserved. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner.

The information presented in this document does not form part of any quotation or contract, is believed to be accurate and reliable and may be changed without notice. No liability will be accepted by the publisher for any consequence of its use. Publication thereof does not convey nor imply any license under patent- or other industrial or intellectual property rights.

Printed in The Netherlands

R75/02/pp13

Date of release: 2004 Nov 08

Document order number: 9397 750 13891

Let's make things better.

Philips Semiconductors



